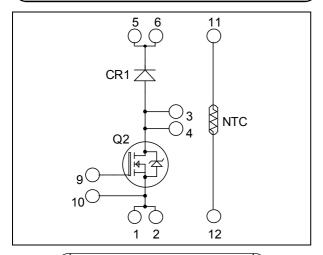
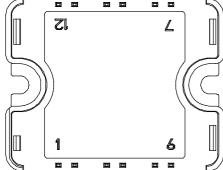


# Boost chopper Super Junction MOSFET Power Module





Pins 1/2; 3/4; 5/6 must be shorted together

## $$\begin{split} V_{DSS} &= 900V \\ R_{DSon} &= 60 m\Omega \text{ max } @ \text{Tj} = 25^{\circ}\text{C} \\ I_D &= 59\text{A} @ \text{Tc} = 25^{\circ}\text{C} \end{split}$$

#### **Application**

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

#### **Features**

- COOLMOS
  - Ultra low R<sub>DSon</sub>
    - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged

#### • CR1 SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### **Absolute maximum ratings**

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		900	V
Ţ	In Continuous Drain Current	$T_c = 25$ °C	59	
1 <sub>D</sub>		$T_c = 80$ °C	44	Α
$I_{DM}$	Pulsed Drain current	150		
$V_{GS}$	Gate - Source Voltage	±20	V	
R <sub>DSon</sub>	Drain - Source ON Resistance		60	mΩ
$P_{D}$	Maximum Power Dissipation	462	W	
$I_{AR}$	Avalanche current (repetitive and non repetitive)	8.8	A	
$E_{AR}$	Repetitive Avalanche Energy		2.9	mJ
$E_{AS}$	Single Pulse Avalanche Energy		1940	IIIJ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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## All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

#### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 25^{\circ}C$			200	^	
		$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 125^{\circ}C$		1000		μА	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 52A$		50	60	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 6mA$	2.5	3	3.5	V	
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			200	nA	

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$ ; $V_{DS} = 100V$		13.6		nF
$C_{oss}$	Output Capacitance	f = 1MHz		0.66		Ш
$Q_{g}$	Total gate Charge	$V_{GS} = 10V$		540		
$Q_{gs}$	Gate – Source Charge	$V_{\mathrm{Bus}} = 400\mathrm{V}$		64		nC
$Q_{\mathrm{gd}}$	Gate – Drain Charge	$I_D = 52A$		230		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		70		ns
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		20		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 600V$ $I_{\text{D}} = 52A$		400		
$T_{\mathrm{f}}$	Fall Time	$R_G = 3.8\Omega$		25		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1.8		I
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.5		mJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		2.52		T
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.7		mJ

#### CR1 SiC diode ratings and characteristics

Symbol	Characteristic	Test Condition	Min	Тур	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			V
Inve	$I_{\rm DM} = I_{\rm DM}$ Maximum Reverse Leakage Current $I_{\rm D} = 1200 {\rm V}_{\rm D}$	V_=1200V	$T_j = 25^{\circ}C$		96	600	μA
1RM		$T_j = 175$ °C		168	3000	μΑ	
$I_F$	DC Forward Current	$Tc = 100^{\circ}C$			30		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_{\rm D} = 300\Delta$	$T_i = 25^{\circ}C$		1.6	1.8	V
V <sub>F</sub>			$T_j = 175$ °C		2.3		<b>v</b>
Qc	Total Capacitive Charge	$I_F = 30A, V_R = 600V$ di/dt = 1000A/ $\mu$ s			120		nC
С	Total Canacitanas	$f = 1 MHz, V_R = 200V$ $f = 1 MHz, V_R = 400V$			288		ъE
	Total Capacitance				207		pF

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#### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit	
D	Junction to Case Thermal Resistance		CoolN	1OS			0.27	°C/W
$R_{thJC}$			SiC D	iode			0.63	C/W
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V	
$T_{J}$	Operating junction temperature range			-40		150		
$T_{STG}$	Storage Temperature Range				-40		125	°C
$T_{\rm C}$	Operating Case Temperature				-40		100	
Torque	Mounting torque	To heatsi	nk	M4	2		3	N.m
Wt	Package Weight					80	g	

#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

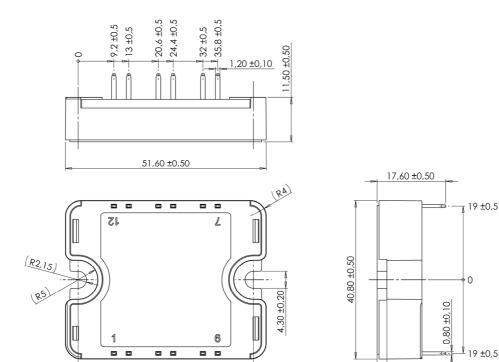
Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: T}$$

45 ±0,20

T: Thermistor temperature  $R_T$ : Thermistor value at T

#### SP1 Package outline (dimensions in mm)

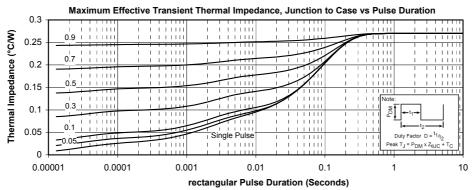


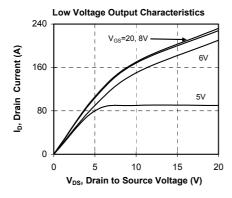
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

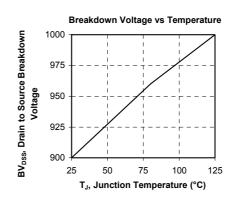
2,50 ±0,20

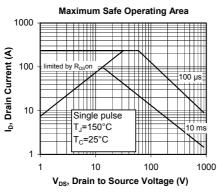


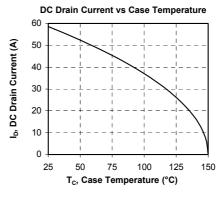
#### **Typical CoolMOS Performance Curve**

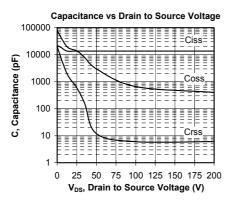


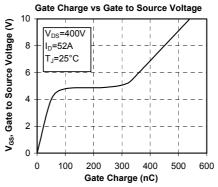




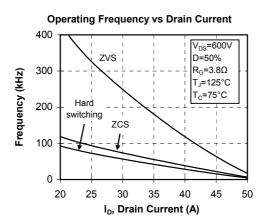


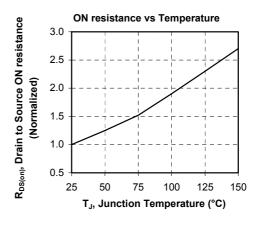


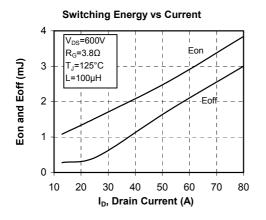


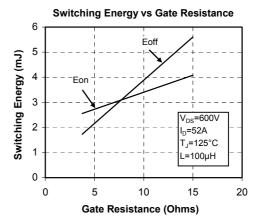






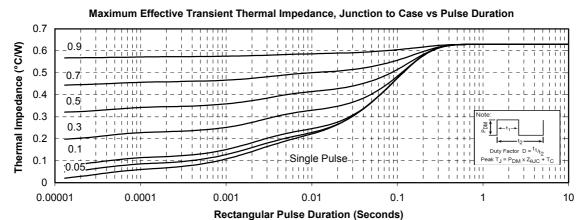


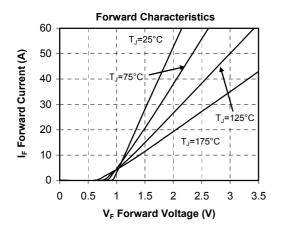


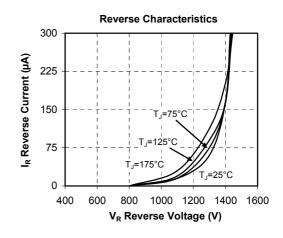


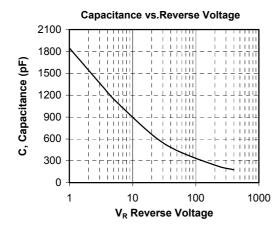


#### Typical CR1 SiC Diode Performance Curve









"COOLMOSTM comprise a new family of transistors developed by Infineon Technologies AG. "COOLMOS" is a trademark of Infineon Technologies AG".

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